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FINAL REPORT FOR THE PROJECT "POLARIZATION EFFECTS IN OPTICAL PROPERTIES OF GaSe CRYSTAL BULK AND SURFACES"

MATERIALS AND CHEMICALS TECHNOLOGIES RESEARCH
INSTITUTE
MARMARA RESEARCH CENTRE
TURKISH SCIENTIFIC AND TECHNICAL RESEARCH COUNCIL

GEBZE/KOCAELI

TURKEY
DECEMBER 2002

December 16, 2002

Dr. Alex GLASS
European Office of Aerospace
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UNITED KINGDOM

<u>Subject</u>: The Final Report (<u>Stage 4</u>) for the Project "POLARIZATION EFFECTS IN OPTICAL PROPERTIES OF GaSe CRYSTAL BULK AND SURFACES" (SPC 02-4008 and CON F61775-02-WE008).

Dear Dr. GLASS,

Please find enclosed the Final Report (Stage4) for the Project 9SPC 02-4008 and CON F61775-02-WE008 that have been prepared according to a Final Work Plan for entire Project and a Final Budget of Suppliers and Equipment. The report is prepared according the requirement to include the declarations, disclaimers and acknowledgment specified by the terms of my contract.

Yours sincerely,

Prof.Dr. Kerim ALLAHVERDİ

Principle Investigator Materials and Chemicals Technologies Research Institute, Materials Division

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INTRODUCTION

Gallium selenide is one of the best laser frequency generation material in the mid IR. Outstanding non-linear optical properties (high value of the non-linear optical coefficient $d_{22} \ge 72 \pm 6 \ pm/V$, birefringence, that makes it possible to satisfy the phase-matching conditions, high optical quality, wide transparency range of $0.65 - 18 \ \mu m$ and high damage threshold $30 \ MW/cm^2$ [1-3]) make this material very useful for sum- and difference- frequency generation, second harmonic generation, optical parametric oscillation, bi-stable switching devices, laser light modulators, polarized optical filters, optical filters tunable by the electric fields etc. Recently a new possibility was found to use this material in the THz range [4]. The type-II difference laser frequency generation with the kilowatt peak power and output wavelength continuously tunable in the range of $4.14 - 28 \ \mu m$ has been achieved in [4]. This opens new perspectives to use this material in atmosphere monitoring, countermeasures, space signal detection etc.

The binding energy of the direct free excitons Ry = 19.5 meV [5] makes it possible to observe them in optical absorption (reflection) spectra at room temperature.

More than 1300 papers were devoted the physical properties of GaSe. Most of them describe the optical and electrical properties when the wave vector of the incident light was directed along the optical c- axis and the current flow in the plane of layers, respectively. About 11 papers were devoted the optical properties of

GaSe in the mid IR $(400 - 10000 \text{ cm}^{-1})$. Most of them describe the results of experiments when the wave vector of incident light was parallel to c- axis.

Due of the layered structure plane-parallel crystals between about 20 μm (and thick) and several millimeters in thickness are easily cleaved with a razor blade. The cleavage plane of GaSe is parallel to the layers so that the samples with excellent surfaces are obtained. Yet in another directions cutting is very problematic. At the same time the value of the angle of synchronism θ is beyond the critical angle of total reflection. Latter extremely limits efficient application of GaSe in non-linear optical laser frequency converters. This makes necessary to cut and polish the crystals under different angle to the cleavage plane into plane-parallel plates with good optical quality.

OBJECTIVES STATED

They are as follows:

to develop the technology of obtaining the plane-parallel plates of GaSe with at least $5 \times 5 \text{ mm}^2$ or larger faces, which contain the optical c- axis; to study optical anisotropy in two polarization ($E \perp c$ and $E \parallel c$, where E is the electric field vector of the electromagnetic wave) in the mid IR; to construct accurate equation that describe the wavelength dependence of the absorption coefficient α in $E \parallel c$ polarization in the mid IR; to explain the anisotropy of absorption mechanism in the mid IR and the mechanism of the free carriers scattering; to study room-temperature anisotropy of the photoluminescence (PL) spectra of the direct free excitons.

EXPERIMENTAL

Equipment and facilities used in the present research:

X-ray diffraction (Shimadzu XDR-600) and X-ray fluorescence (Philips PW

2404;

high resolution transmission TEM (JEOL - JEM100C) and scanning SEM (JSM $\,$

- 840) microscopes;

IR Fourier transform spectrometers (Perkin Elmer Spectrum 1 FTIR and Bomem

DA-3);

Ar⁺ laser and DFS-24 spectrometer;

facilities and powders for cutting and polishing the crystals, visual microscopes, digital micrometer.

RESULTS AND DISCUSSION

Four distinct modifications, the β -, the ε -, the γ - and the δ - type were reported for GaSe, differing by the stacking order of two-dimensional Se-Ga-Ga-Se sheet [5]. The difference between types arises from the stacking of layers and from the number of layers per unit cell. The ε - type $[(D_{3h}^{-1} \text{ space group (SG)}, \text{ contains 2 layers per unit cell}]$ is the most common and best investigated. Up to now the existence of the β - type $(D_{6h}^{-4} \text{ SG}, \text{ two layers per unit cell})$ has not yet been confirmed. The γ - type has three layers $(C_{3v}^{-5} \text{ SG})$, the δ - type contains four layers per unit cell $(C_{6v}^{-4} \text{ SG})$. Normally the crystals grown by the Bridgman method are the mixture of ε - and γ - types, with the predominant content of former.

Starting the project *first* we characterized the crystal by help of XDR-600 Shimadzu X-ray diffractometer. Observed diffraction peaks at 11.10° ; 22.26° ; 28.60° ; 32.30° ; 39.76° ; (broad weak); 45.62° ; 48.54° ; 54.10° ; 57.92° [see Attachment **XDR** to the present report. Same Figure with more detailed description of the results has been presented in the Interim Report (Stage2), which have been sent to EOARD in June 17, 2002)] were identified according to the Data Base: Hanawalt Search Manual, Inorganic Phases, Powder Diffraction Files, Sets 1-45, International Centre for Diffraction Data, Pensilvaniia 19073-3273, USA, Copyright JCPDS- International Centre for Diffraction Data, 1995. The results of identification showed that the crystals belong to ε - modification with the lattice parameters a = b = 3.74 Å, c = 15.907 Å, c/a = 4.243. Attachment **XDR1** represents the results of identification of the observed diffraction peaks according to corresponding Muller's indexes. The results of X- ray fluorescence measurements showed the next content of the initial components: **Ga** in the range from 45.914 % (Se- 54.084 %) to 45.742

(Se- 54.258 %). Some samples had the composition Ga- 47.174 %, Se- 52.826 %). Unintended impurities were detected also in some samples: Ni (0.220 %), Mn (0.049 %). No noticeable difference was observed in the optical properties of samples with different content of chalcogenide atoms.

Characterization using the thermoelectric power measurements showed that all crystals were p- type.

The hexagonal symmetry was confirmed also by the TEM and SEM measurements technique. To study the crystals by TEM technique a method was develop to obtain thin (less than 500 Å) films of GaSe. Method developed opens new perspectives for experimental investigations of quantum sized effects in the layered GaSe- type crystals. The details of this method were described in the interim Report (Stage2). In some cases non-identified features perturbed the pattern. This fact says in a favor that the crystals consist of the mixture of different modifications with predominant content of ε - type (in agreement with the results of optical measurements using confocal Raman and PL microscopy [6]).

Special attention at the beginning of project we made on developing a technique of preparing the plates of GaSe crystals (aperture 5 x 5 mm² or larger), containing the optical c- axis. Main steps of developed technology include:

- 1. Embedding the single crystal blocks into some binder.
- 2. Cutting the crystal blocks into plane-parallel plates.
- 3. Polishing the plates.

Detailed description of above mentioned 3 steps were described in the Interim Report (Stage2), that has been sent to EOARD on June 17, 2002.

We found that good results were obtained when using the Buchler Epoxide Resin as a binder. Cutting with a sewing wire (with the wire thickness about 250 μ m) and

with commercial Struers Minton device with rotating diamond coated wheel gave nearly the same results, the latter being more fast and productive. Final polishing of surfaces were performed with Buchler Matermet Colloidal Silica (SiO₂) suspension with a partial diameter 0.05 μ m. Polished surface were examined by ZEISS AXIOYTECH optical microscope in reflected and transmitted light. Obtained surfaces were compared with freshly cleaved one oriented in the (001) plane. Freshly cleaved surfaces were more perfect. Nevertheless, polished plates were quite good optical quality. They had mirror-like plane-parallel surfaces that allowed to read the printed text onto the polished surface in the reflected light. Good optical quality was confirmed also when comparing the transmission spectra of our samples (for E // c in the range of 400 – 700 cm^{-1}) with those presented in Ref. [7]. Maximum transmission for 8.78 mm thick sample was ~ 55 % (see Attachment IR1), whereas for 0.84 mm plate presented in Ref. [7] it was ~ 20 % (we understand that the transmission is dependent also from the impurity content).

The transmission spectra of freshly cleaved samples were compared with the spectra of polished samples. For $E \perp c$ the spectra were identical with a small difference in transmission. Transmission of freshly cleaved sample was about 5 to 7% higher for the sample with same thickness. The transmission spectra of 1.061 mm thick freshly cleaved sample measured in $E \perp c$ at room temperature is presented in Attachment IR2.

5 samples were prepared. These samples have been sent to the Materials Directorate of the WPAFB, Ohio to Dr. Nils FERNELIUS for polarized spectra measurements in the mid IR. The samples were as follows:

8 x 6.3 x 8.78 mm³ (length x width x thickness) Sample No1.

 $8 \times 3.8 \times 6$ mm³ ----- Sample No2.

Each of these samples may be used for anisotropy measurements of the absorption spectra in $E \perp c$ and $E \parallel c$ at room temperature. Some of them that were not fully embedded in epoxy binder along the perimeter (sample No2, No3, No5) may be used also for the low-temperature experiments.

Detailed explanation how to handle these samples and recommendations how to mount them onto the sample holder in case of low-temperature measurements were presented in the Interim Report (Stage2).

Attachment IR1 shows non-polarized room-temperature transmission spectrum of 8.78 mm thick crystal (Sample No1) when the wave vector of the incident light was perpendicular to polished plane. The absorption bands at 621, 889, 1073 (seen as a weak shoulder) and 1270 cm⁻¹ are clearly resolved. Bands in the range below 600 cm⁻¹ are not seen due of high thickness of the sample. Transmission spectrum of 2.48 mm thick sample measured at the same conditions as for 8.78 mm thick GaSe is presented in Attachment IR3. Besides the bands mentioned above the bands at 540, 945, 1095 cm⁻¹ are seen. The prominent feature (when analyzing the number and the shape of the lines) of these spectra is a sharp line 891 cm⁻¹. To our knowledge, this line was observed for the first time. Nature of this line will be discussed later.

Measurements of the transmission spectra of samples (from freshly cleaved surface and the surface containing the optical axis) with different thickness in non-polarized and polarized light revealed the bands that are shown in **Table 1**. **Table 1** summarizes the data published in Ref. [7-15] and the results obtained in the present Project. 8 and 5 absorption bands were observed at 420, 448, 482, 488, 512, 540,

551, 619 cm^{-1} and 498, 891, 945, 1095, 1270 cm^{-1} in $E \perp c$ and $E \parallel c$ geometry, respectively. Nature of these bands will be discussed later. Our results are in a fairly good agreement with those published by different authors.

Anisotropy of the mid IR absorption

Room-temperature transmission spectra of 8.78 mm thick GaSe in two polarization $E \perp c$ ("o-ray") and E // c ("e-ray") is given in Attachment IR4. The absorption band at 498 cm^{-1} is not seen due to a higher thickness of sample when comparing with that of 2.48 mm thick sample (Attachment IR3). The absorption bands at 891 cm^{-1} and 1093 cm^{-1} are clearly resolved, whereas the bands at 945 and 1093 cm^{-1} are seen as a weak shoulder. Different character for the transmission-wavelength dependencies for o- and e- rays follows from the Attachment IR4, especially in the spectral range below $\sim 2250 \ cm^{-1}$. The transmission for e- ray decreases gradually to longer wavelength starting from $\sim 2250 \ cm^{-1}$, whereas for o-ray transmission decreases sharply from $\sim 750 \ cm^{-1}$. To reveal the origin of such anisotropy we performed the calculations of the absorption coefficient α . The absorption coefficient was calculated by using the formulae given in Ref. [16]:

$$\alpha = (1/d) \ln \left[2TR^2 / \sqrt{(1-R)^4 + 4T^2R^2} \right) - (1-R)^2 \right]$$
 (1)

where d is the sample thickness, T and R is the transmission and reflection, respectively.

According to Ref. [16], in the transparency range reflection coefficient may be calculated according to formulae:

$$R = (n-1)^2/(n+1)^2$$
 (2)

where n is the refractive index.

To calculate R we used n = 2.8 which is the average value of sum for the ordinary and extraordinary refractive indexes in the transparency range. Room-temperature wavelength dependencies of the absorption coefficients for both orientations (polarization of the incident electromagnetic light relative to the optical c- axis) are shown in the Attachment IR5. These dependencies were calculated using the formulae (1) and the data of Attachment IR4.

To explain the anisotropy in the transmission spectra we first supposed, that the absorption in E // c in the spectral range below 2250 cm^{-1} are due of the free carriers that move along the optical c- axis.

In case when the relaxation time τ does not depend on time, for the free carriers absorption Drude theory gives [16]:

$$\alpha = Nq^2 \lambda^2 / m^* 8 \pi^2 nc^3 \tau \tag{3}$$

where N is the carriers concentration, q is the electron charge, λ is the wavelength, m* is the effective mass of the free carriers, c is the speed of light.

Scattering mechanism for the case when τ depends on the electron energy brings about the following wavelength dependent terms:

$$\alpha = A\lambda^{1.5} + B\lambda^{2.5} + C\lambda^{3.5} \qquad (4)$$

where A, B and C are constant.

The dominant term depends on the scattering mechanism. Scattering by the acoustic, optical phonons and by the ionized impurities gives $A\lambda^{1.5}$, $B\lambda^{2.5}$ and $C\lambda^{3.5}$,

respectively. It was found that the wavelength dependence of the absorption coe3fficient in the spectral range of $2 - 18 \mu m$ obeys the formulae:

$$y = y_o + A |x - x_c|^P$$
 (5)

with $y_0 = 0.239$, $x_c = 3.91$, A = 0.048 and P = 1.40.

The power law dependence of the absorption coefficient on the wavelength allows concluding that it is due of the free carriers. P = 1.40 says in a favor of fact, that the dominant scattering mechanism at room temperature is the acoustic-mode scattering. Those given in Ref. [17] supplement this results. The authors of Ref. [17] have been measured the temperature dependencies of the electrical resistance and the Hall constant R_H for n- and p- type GaSe (n- type crystals were grown by the vapor transport method using iodine as a transporter). All measurements were performed in geometry when the current was flowing in the plane of layer (perpendicular to c- axis). The temperature dependence of the Hall mobility derived from these measurements allowed to conclude that in the temperature range of ~ (700 – 300 K) the holes scatter mainly due of the homopolar optical phonons [17]. Attentive examination of Fig. 4 (see mobility=temperature dependence marked by symbol ∇ in Fig. 4 [12]) shows however that for p- type crystal the scattering mechanism is different in the range of 500 - 300 K. For some p- type crystals the mobility-temperature dependence changes the slope at ~ 300 K. We believe that the difference in the free carriers scattering mechanism obtained in the present research and in Ref. [17] I due of the different geometry of measurements. This says in a favor of fact that the scattering mechanism is different in two mutually perpendicular directions. By the other words the carriers moving in the plane of layers and in the direction of the optical c- axis reveal different scattering

mechanism. Scattering for the carriers moving in the layer plane (current flow in the cleavage plane XY) is due of homopolar optical phonons, whereas the acoustic vibrations are predominant scattering for the carriers moving in the direction parallel to c- axis (results of the present research). This conclusion reflect the anisotropy of the physical properties of GaSe and important when creating different devices. Due to difficulty to prepare good quality crystals the authors of Ref. [17] could not measure the electrical resistance and the Hall coefficient when the current flows parallel to c- axis.

Anisotropy of the R_H coefficient measurements in the temperature range from 100 to 500 K was reported in Ref. [18]. The holes mobility derived from these measurements in the range of 110 - 238 K and 238 - 500 K exhibited temperature dependence of the form $\mu \sim T^n$, where n=2.1 (current flows in the plane of layer) and n=-1.62 (current flows parallel to c- axis), respectively. n=2.1 and n=-1.62, say in a favor of optical and acoustic phonons scattering mechanism, respectively. Stron0g anisotropy $R_{H,I}/R_{H/I} \approx 18$ was reported in Ref. [18].

Acoustic-mode scattering mechanism at room temperature for the carriers moving along the optical c- axis [18] is in fairly good agreement with our conclusion, obtained from the optical measurements.

The wavelength dependence of the absorption coefficient for $E /\!/ c$ when the free carriers absorption has been subtracted from the spectrum shown in Attachment IR5 is presented in the Attachment 6a. It is seen that maximum of the absorption coefficient does not exceed 2.5 cm⁻¹. The bands at 7.9 μ m (1270 cm⁻¹), 9.1 μ m (1093 cm⁻¹), 10.5 μ m (949 cm⁻¹) and relatively strong band at 11.2 μ m (891 cm⁻¹) are clearly seen. Most probably the origin of these band and the other absorption bands observed in the present research are due of the multi-phonon absorption and the

localized mode of vibrations induced by uncontrolled impurities. This question is beyond the scope of the present project and may a question of separate investigation.

Especial attention was made to the absorption band at 891 cm⁻¹ (110 meV). This was made because this line when comparing with others is quite sharp and relatively strong. The origin of this line may arise also due of the hole transitions from the first lower lying valence band in the center of the Brillouin zone to the top of the valence band ($\Gamma_6^+ \to \Gamma_4^-$ transition [19,20]. The results of the band structure calculation do not contradict this. According to Ref. [19,20] two upper lying valence bands are formed due of the interlayer splitting. At the same time it is possible to suppose that the splitting is about several hundred meV. To clarify nature of this band further research is necessary (e.g. low-temperature measurements, measurements under high hydrostatic pressure etc.).

PL anisotropy

The spectra were excited with 5145 Å (E = 2410 eV) line of an Ar⁺ laser (power < 20 mW). The emitted light was dispersed through a spectrometer DFS – 24 and detected with liquid nitrogen cooled CCD detector. To get the energy positions and the intensity of the PL peaks, the experimental spectra were fitted by a Lorentzian line shape. The PL spectra of GaSe from the surface containing the optical c- axis are shown in the Attachment 6. Left Figure shows the spectra when the c- axis of the sample was vertically oriented relative to the ground and the analyzer was oriented horizontally, relative to the c- axis ($\theta = 90^{\circ}$). θ is the angle between the optical c- axis and the polarization of the emitted light. Right Figure represents the PL spectra measured at the same conditions as in left Figure, but the analyzer was

oriented vertically to the optical c- axis ($\theta = 0^{\circ}$). The measurements were done in the range of $0^{\circ} < \theta < 180^{\circ}$.

Variation of the PL peak wavelength and the PL intensity versus angle θ is shown in the Attachment 7 and Attachment 8, respectively. As it is seen (Attachment 8) when the laser light was oriented horizontally (perpendicular to caxis), then the peak position of the light emitted by sample does not noticeable depended on the position of the analyzer. At the same time when the excited light is vertical (parallel to c- axis), then the peak center depends on the position of the analyzer. For E // c the peak position is at 632 nm, in comparing with 627 nm when E \perp c. The 5 nm shift is beyond the accuracy of our measurements and this value reflects the anisotropy of the PL peak position in GaSe at room temperature in two different geometries.

The anisotropy of the PL intensity for both polarizations are shown in Attachment 8. As it is seen they are less informative and looks like similar with a small difference at small angles.

CONCLUSION

X- ray diffraction analysis showed that the melt-grown crystals used in the present Project belong to ε - modification and reveal p- type conductivity. The lattice parameters are a = b = 3.74 Å, c = 15.907 Å, c/a = 4.243, space group $D_{3h}{}^{l}$, contains two layers per elementary unit cell.

We have developed a simple but effective technology to achieve optical-quality cutting and polishing of GaSe at an arbitrary angle to the optical axis. Several samples containing the optical axis were prepared and the quality of these samples was analyzed by mid IR absorption spectroscopy and visual inspection under the microscope. The technology developed opens new perspectives for practical applications of GaSe in laser wave generation and mixing experiments.

Five slabs of GaSe containing the optical c- axis have been sent to the Materials Directorate of the US Air Force Wright-Patterson Laboratory to Dr. N. Fernelius for further measurements and characterization.

The anisotropy of the mid IR absorption spectra of GaSe was measured at room temperature for the radiation polarized perpendicular and parallel to the optical c-axis. It is shown that the anisotropy of absorption arises due of the free carriers absorption recorded in E // c. The carriers that move along the optical c- axis are mainly scatter by the longitudinal acoustic vibrations.

New absorption bands were recorded in E // c at 891, 945, 1093 and 1270 cm^{-1} . Most probably, these bands are due of the multi-phonon absorption and the localized mode of vibrations induced by uncontrolled impurities. To clarify nature of these bands further research are necessary.

Polarization anisotropy of the PL spectra studied in the present work are less informative and interesting. The only feature we may stress on is that the peak center difference between the spectra measured in E // c and $E \perp c$ is about 5 nm.

The results of present research were submitted for publication to the Journal of Applied Physics. Submitted paper by K. Allakhverdiev, N. Fernelius, F. Gashimzade, J. Goldstein, E. Salaev, Z. Salaeva entitled "Anisotropy of Optical Absorption in GaSe Studied by mid-IR Spectroscopy" are given at the end of the present Report.

As a perspectives for future to explain the anisotropy of the absorption and the origin of lines observed in E // c spectrum one needs to obtain plates for optical measurements with the optical c- axis in the plane of face. Using these plates the optical absorption will be measured at different temperatures. Using these plates at a variety of temperatures should obtain data for explaining the anisotropy of optical absorption in GaSe. Theoretical model should be developed to predict the vibration frequencies of the impurity atoms. The results of calculation will be compared with the experimental data. The results of this effort will be useful for creating some prototype devices, such as optical parametric oscillators, tunable laser sources in the mid-IR and others.

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We would like to point out the following disclaimers: all described results, findings, conclusions and recommendations for future research are belong to the authors and do not necessarily reflect the views of the European Office of Aerospace Research and Development, Air Force Office of Scientific Research, Air Force Research Laboratory.

In accordance with Defence Federal Acquisition Regulation 252.227-7036, Declaration of Technical Data Conformity (Jan 1997) "The Contractor, TUBITAK, Marmara Research Center, hereby declares that, to the best of our knowledge and belief, the technical data delivered here with under Contract No. F61775-02-WE008 is complete, accurate, and complies with all requirements of the Contract".

In accordance with the requirements in Federal Aquisition Regulation 52.227-13, Patent Rights-Acquision by the U.S. Government (Jun 1989) "I certify that there were no subject inventions to declare as defined in FAR 52.227-13, during the performance of this Contract".

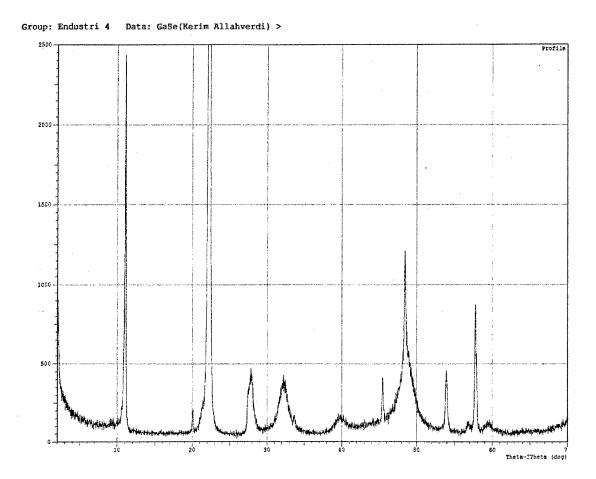
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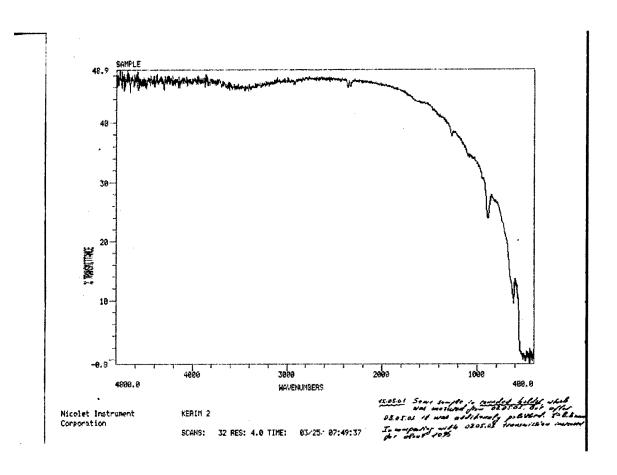
Attachment XRD. Room-temperature X-ray diffraction pattern of GaSe powder versus the angle θ .

37-0931									Wavelength 1.54056
GaSc					20	Int	b	k	1
Gallium Selenide					11.100*	62	0	o	2
					22.261*	100	0	0.	4
					27.601*	4	1	O	0
					28.001*	6	1	0	1
					32.301*	5	1	0	3
Rad.: CuKa	1: 1.5417	Filter: Mono□	·a-	sp: Diffractometer	33.801*	2	0	0	6
Cut off:	Int.: Diffi	ract. 1/1	cor.:		39.762*	1	1	0	5
Ref. Anis, M., Nazar, J. Mater. Sci. Lett., 2, 471 (1983)					45.622*	10	0	Ò	8
					48.542*	17	1	1	0
					54.102*	5	1	1	4
			******		56.903*	1	0	2	0
Sys.: Hexag	onai	S.G.;			57.923*	27	2	0	2
a: 3.749	b :	c: 15,907	A:	C; 4.2430	59.502*	1	1	Ο.	9
a. ş. 149	.	C. 13,507		C., 4.2-150	59.502*	1	0	2	3
x;	3 :	y:	Z :	mp:	71.023*	17	0	0	
Ref: Ibid.					78.803*	2	1	1	10
icci. Ima.					78.803*	2	2	1	2
					85.365*	20	0	0	
	Dm:	SS/FOM	: j7=6(.0	051, 60)	90.784*	5	l	1	12

193.62.

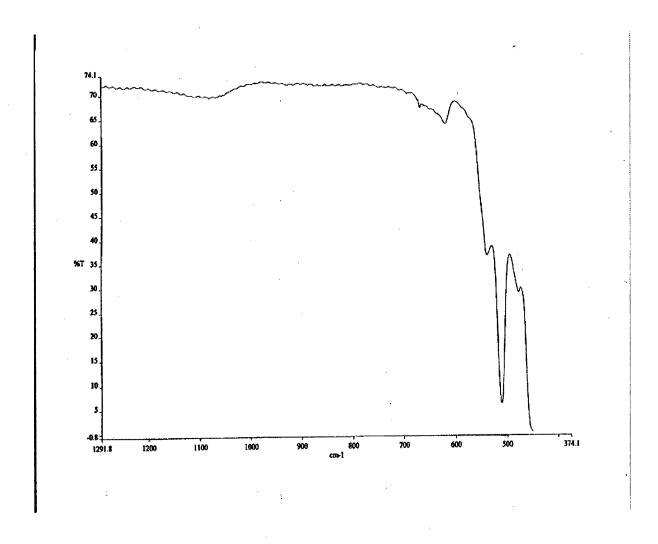
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Attachment XDR1. The result of identification of the diffraction peaks, given in the Attachment XDR.

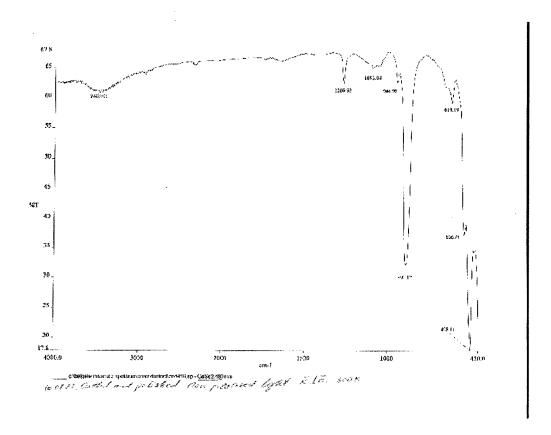


Attachment IR1. Room-temperature transmission spectrum of 8.78

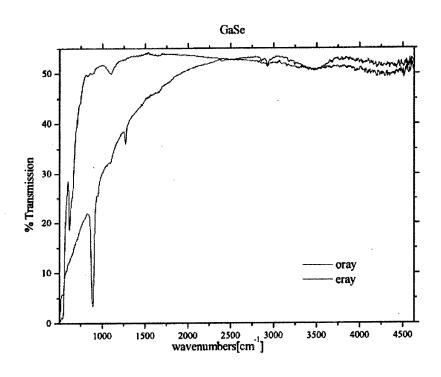
mm thick GaSe sample (Sample No1) measured in
non-polarized light when the wave vector of the
incident light was perpendicular to polished plane
(110).



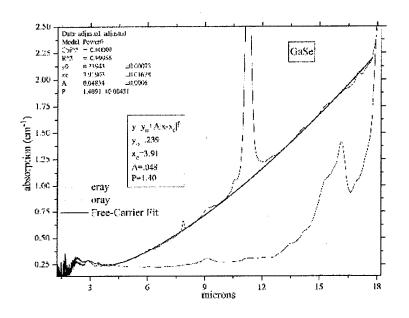
Attachment IR2. Room-temperature transmission spectrum of 1.061 mm thick GaSe measured from freshly cleaved surface in non-polarized light.



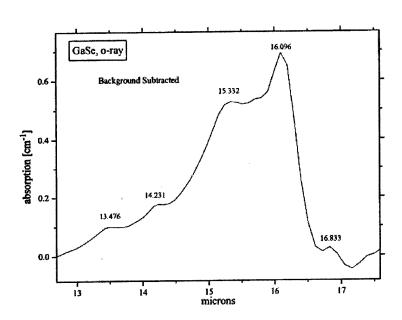
Attachment IR3. Transmission spectrum of 2.48 mm thick GaSe plate. Conditions of measurements are same as in Attachment IR1.



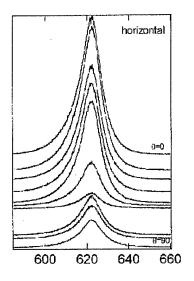
Attachment IR4. Room-temperature transmission spectra for 8.78 mm thick GaSe plate for $E \perp c$ ("o-ray") and $E \parallel c$ ("e-ray") geometry.

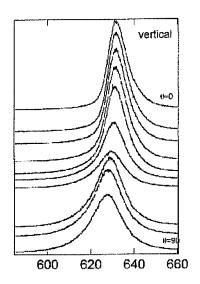


Attachment IR5. Room-temperature absorption coefficient for GaSe in $E /\!/ c$ (bolded line), calculated using formulae 1 using the data of the Attachment IR4. Insert shows the formulae and the value of parameters according which the wavelength dependence for the absorption coefficient for "eray" is adjusted.

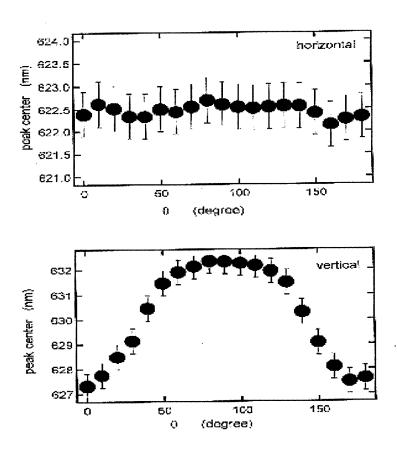


Attachment 6a. Room-temperature absorption coefficient for GaSe in $E /\!\!/ c$ geometry for case when the free carriers absorption has been subtracted from the spectrum shown in the Attachment IR5.

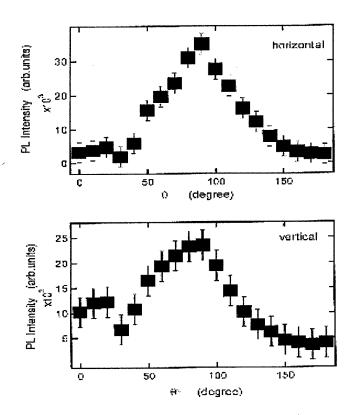




Attachment 6. Room-temperature PL spectra of GaSe plate containing the optical c- axis and excited with a 5145 Å line of an Ar^+ laser, when the analyzer was oriented horizontally (left) and vertically to the optical c- axis (right). θ is the angle between the optical c- axis and the polarization of the light emitted.



Attachment 7. Polarization dependence of the PL peak center of GaSe slab containing c- axis for horizontally polarized excited light.



Attachment 8. Polarization dependence of the PL peak center of GaSe slab containing c- axis for horizontally and vertically polarized excited light.

Table 1. IR absorption (reflection) bands of GaSe. $^{\bullet}$ Data for freshly cleaved crystal 1 Data for ν_{TO} (transverse optical) and ν_{LO} (longitudinal optical) phonons obtained from IR restrahlen spectra (freshly cleaved and surfaces containing the optical caxis). References are mentioned according to that given at the end of the Final Report.

Ref.	Band position [cm ⁻¹], E⊥c	Ref	Band position [cm ⁻¹], E c
[7] ¹	231 _{TO} , 254 _{LO} , 423, 445, 476, 511, 539	[7] ¹	237 _{TO} , 246 _{LO} , 318, 360, 416, 495
[8]*	211 _{TO} , 420, 448, 481, 488, 512, 539,		,
	551, 619		
[9] ¹	214 _{TO} , 255 _{LO}		
[10]*	20, 20K		
$\begin{bmatrix} 11 \end{bmatrix}^1$	215 _{TO} , 252 _{LO}	[11]	236 _{TO} , 247 _{LO}
		1	
$[12]^{1}$	214, 254		
[13]*	214 _{TO} , 252 _{LO}		
[14]	212 _{TO} , 254 _{LO}	[14]	237 _{TO} , 245 _{LO}
$[15]^{1}$	212, 255	1	
Presen	t 420, 448, 482, 488, 512, 540, 551,	420, 448, 482, 488, 512, 540, 551, 619	
work			

PAPER SUBMITTED TO THE JOURNAL OF APPLIED PHYSICS

For submission to Journal of Applied Physics

Anisotropy of Optical Absorption in GaSe Studied by mid-IR Spectroscopy K. Allakhverdiev^{b,c)}, N. Fernelius^{a)}, F. Gashimzade^{c)}, J. Goldstein^{a)}, E. Salaev^{c)}, Z. Salaeva^{b,c)}

ABSTRACT

Slab samples of ε - GaSe have been prepared with the optical axis (the c-axis) in the plane of the face. Previously, most optical studies were made on slabs cleaved from crystals, which have the c- axis perpendicular to the face. The infrared absorption spectra of ε - GaSe has been measured at room temperature in the spectral range from 4000 to 400 cm⁻¹ for the e-ray (polarized parallel to the optical axis), and the o-ray (polarized perpendicular to the optical axis). The maximum value of the optical absorption coefficient, α, for both geometries, does not exceed 2.5 cm⁻¹ (E || c). We find an anisotropy in the transmission, in the spectral range below ~ 2250 cm⁻¹, due to the free carrier absorption, seen only in the e-ray. At T = 300 K, acoustic lattice vibrations are the dominant scattering mechanism for carriers moving parallel to the c- axis. New absorption bands were observed in the e-ray spectrum at 891, 945, 1093 and 1270 cm⁻¹. These bands may be due to multiphonon absorption, or to localized vibrational modes stemming from unintentional impurities. It is suggested that a sharp absorption at 891 cm⁻¹ may be due to hole transitions from the lowest-lying valence band in the center of the Brillouin zone, to the top of the valence band $(\Gamma_6^+ \to \Gamma_4^- \text{ transition})$.

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I. INTRODUCTION

Several different properties are required of a crystal if it is to be of practical use in nonlinear optical (NLO) devices. These include a high nonlinear optical coefficient, a high damage threshold, a suitable transparency range, and a low absorption coefficient. For purposes of serving as an NLO material in the mid-IR, GaSe possessés excellent values for all these properties, as has been extensively documented in the literature. Yet, its practical implementation in NLO devices remains limited due to a fatal flaw - its softness. To achieve birefringent phasematching, it is generally necessary to be able to cut and polish the faces of an NLO crystal at an arbitrary angle to the optical axis (for GaSe, this is the c-axis, along the [001] direction). However, GaSe has a layered structure, with weak van der Waalslike bonds between the layers, making it extremely difficult to cut and polish, except for crystal faces in the plane of cleavage (perpendicular to the optic axis). This feature drastically reduces GaSe's utility as an NLO crystal of practical use, and also complicates access to measurement of its basic properties. For example, although over 1300 papers have been published on GaSe 1-10, we are aware of only four which investigate transmission of the crystal's e-ray to any extent, and these focused only on the vicinity of the Reststrahlen band (see Table 1 for details).

In the present article we report mid-IR absorption measurements on ε- GaSe single crystals which were grown from the melt. In Sec. II we describe our original method of preparation of the plane-parallel samples, which contain the optical c-axis, and the experimental procedures. The results of the mid-IR absorption measurements are presented and discussed in Sec. III. Finally in Sec. IV we give the conclusions.

II. EXPERIMENT

Over the last few years, we have developed a simple but effective technology to achieve optical-quality cutting and polishing of GaSe at an arbitrary angle to the optical axis. Specifically, we encase the uncut GaSe boule within a firm polymer resin, forming a hard "puck". The puck is then cut and polished, as a whole. The re-enforcement provided by the polymer resin prevents the deformation of the GaSe. With careful polishing methods, we have reproducibly obtained mirror-smooth surfaces, on faces of area greater than 1cm², parallel to the optical axis. (The polymer resin can then be trimmed away, or left on, depending on one's purpose). As a result of this technology, we have been able to measure and compare the transmission of both the o- and the e-ray of GaSe.

Undoped, p- type GaSe crystals were grown in evacuated quartz ampoules (10⁻⁵ Torr) by the Bridgman method. From the boules (diameter 15 mm), slabs of different thickness were easily cleaved with a razor blade. The slabs were embedded in a special polymer resin, and were cut into plane-parallel plates of different thickness. The slabs were cut by means of a low-speed diamond saw. The plates were gently polished using alumina grit to reach mirror-like surfaces. The resulting surfaces were sufficiently mirror-smooth to permit easy reading of printed text reflected from their surfaces. However, their overall smoothness is not quite as perfect as that obtainable by cleavage. Room-temperature transmittance was measured in the mid IR (1.5 – 18 μm) using a Bomem DA-3 spectrometer.

III. MID-IR ABSORPTION SPECTRA

First, we compared the transmission spectra of freshly cleaved samples with the spectra of our specially-polished plates. For the o-ray ($E \perp c$), the spectra were identical with a small difference in transmission. Transmission of freshly cleaved

samples was about 5 to 7 % higher for samples of the same thickness. The optical quality of our samples also compared favorably with the highest-quality samples reported in the literature². Maximum transmission for our 8.8-mm thick sample (Fig. 2) was ~ 55 %, whereas for the 0.84-mm plate reported in the literature it was ~ 20 %.

Fig. 1 presents non-polarized transmission spectrum of 2.66-mm thick GaSe crystal, with the wave vector of the incident light parallel to the layer planes. New absorption bands are clearly resolved at 891, 945, 1093 and 1270 cm⁻¹. These lines are listed in Table 1. The e- and o- ray transmission spectra of our 8.8 mm thick GaSe plate are shown in Fig. 2. The absorption bands at 891 cm⁻¹ and 1270 cm⁻¹ are clearly resolved, whereas the bands at 945 cm⁻¹ and 1093 cm⁻¹ are seen as weak shoulders. The character of the transmission's wavelength dependence differs for the two polarizations in the spectral range below ~ 2250 cm⁻¹. The transmission of the e-ray decreases gradually to longer wavelength starting from ~ 2250 cm⁻¹, whereas the o-ray transmission decreases sharply from ~ 750 cm⁻¹.

The absorption coefficient α was calculated using the equation¹¹:

 $\alpha = (1/d) \ln[2TR^2/\sqrt{((1-R)^4 + 4T^2R^2) - (1-R)^2}]$ (1) where d is the sample thickness; T and R are the transmission and reflection, respectively. In the transparency range, R was calculated using the equation¹¹:

$$R = (n-1)^2/(n+1)^2 \qquad (2)$$

where n is the refractive index. To calculate R we used n = 2.8. Room-temperature wavelength dependencies of the absorption coefficients, for both geometries, are shown in Fig. 3. The dependencies were calculated using Eqn. (1), and the data of Fig. 2.

For free-carrier absorption, when the relaxation time, τ , is time-independent, Drude theory gives¹¹:

$$\alpha = Nq^2 \lambda^2 / m^* 8 \pi^2 nc^3 \tau$$
 (3)

where N is the carrier concentration, q is the electron charge, λ is the wavelength, m^* is the effective mass of the free carriers, and c is the speed of light. When τ depends on the electron energy, α can be expected to exhibit a wavelength dependence of the form:

$$\alpha = A\lambda^{1.5} + B\lambda^{2.5} + C\lambda^{3.5}$$
 (4)

where A, B and C are constants. The dominant term depends on the scattering mechanism. Scattering by acoustic phonons, optical phonons and ionized impurities gives rise to the terms $A\lambda^{1.5}$, $B\lambda^{2.5}$ and $C\lambda^{3.5}$, respectively. For GaSe, we found that the wavelength dependence of the absorption coefficient, in the spectral range of 2 - 18 μ m, obeys the equation:

$$y = y_0 + A(x - x_c)^P$$
 (5)

with $y_o = 0.239$, $x_c = 3.91$, A = 0.048 and P = 1.40. The power law dependence of the absorption coefficient on the wavelength indicates that the long-wavelength absorption is due to free carriers. Moreover the value of P = 1.40 implies that the dominant scattering mechanism at room temperature is due to acoustic phonons.

Our results complement Hall effect measurements found in the literature 12,13 . Hall measurements indicate that, for electrons propagating perpendicular to the caxis, homopolar optical phonons are the primary scattering mechanism 12 , while for carriers propagating parallel to the c-axis acoustic phonons dominate the scattering interactions 13 . The Hall measurements indicated an anisotropy in the Hall coefficient, R_H , of $R_{H,I}/R_{H||} \approx 18$. The conclusions from these electrical measurements are in agreement with those reached through our optical work.

The wavelength dependence of the e-ray absorption coefficient, with the free carrier absorption subtracted out, is shown in Fig. 4. We find that the maximum absorption coefficient does not exceed 2.5 cm⁻¹. The bands at 1270 cm⁻¹, 1093 cm⁻¹, 945 cm⁻¹ and the relatively strong band at 891 cm⁻¹ are clearly evident. The most likely origin of these bands would be multi-phonon absorption, and localized vibration modes due to unintentional impurities. The results of the X-ray fluorescence measurements indicated the presence of Ni (0.220 %) and Mn (0.049 %) atoms in our crystals, unintentionally introduced during synthesis and growth.

It is possible that the sharp absorption at 891 cm⁻¹ (110 meV) is due to a hole transition from a low-lying valence band in the center of the Brillouin zone to the top of the valence band (the $\Gamma_6^+ \to \Gamma_4^-$ transition^{14,15}). This would be in agreement with published band structure calculations, which indicate that the two uppermost valence bands in GaSe are split, their degeneracy removed due to interlayer splitting. The calculations indicate that the energy difference between these bands is on the order of several hundred meV. Although it is not possible to calculate the exact value of the splitting, the value indicated by the calculations would be in agreement with such an assignment. Admittedly, clarifying the origin of this band requires further research, and is beyond the scope of the present work.

IV. CONCLUSIONS

In conclusion, the room-temperature mid-IR absorption spectra of GaSe were measured for both the e-ray (polarized parallel to the optical axis) and the o-ray (polarized perpendicular to the optical axis). It is shown that the anisotropy of the absorption arises due to free carrier absorption, seen only in the e-ray. The free carriers that move parallel to the optical c- axis are mainly scattered by the

longitudinal acoustic vibrations. New absorption bands were recorded in the e-ray at 891, 945, 1093 and 1270 cm⁻¹. The most likely origin of these lines would be multi-phonon absorption and the localized vibrational modes of unintentional impurities. It is not excluded that the sharp absorption band at 891 cm⁻¹ is due to Γ_6^+ $\rightarrow \Gamma_4^-$ hole transitions in the center of the Brillouin zone.

ACKNOWLEDGMENTS

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- M. Schlüter, J. Camassel, S. Kohn, J. Voitchovsky, Y. Shen, M. Cohen,
 Phys. Rev. <u>B13</u>, 3534 (1976).

FIGURE CAPTIONS.

Fig 1 Non-polarized room-temperature transmission spectra of 2.66 mm thick GaSe plates. The thin line is from a plate obtained by cleaving a boule, such that the caxis is perpendicular to the face of the sample. The thick line is from a plate created by our polshing method, for which the caxis is parallel to the face of the sample. These two samples were obtained from two separate boules.

- **Fig.2** Room-temperature polarized transmission spectrum of 8.8 mm GaSe plate for $E \perp c$ ("o-ray") and $E \parallel c$ ("e-ray", bolded line) geometry.
- Fig. 3 Room-temperature wavelength dependence of the absorption coefficient for the $E \parallel c$ and $E \perp c$ geometries (bolded and thin line, respectively), calculated using the Eqn. 1 and the data of Fig. 2.

Fig. 4 Room-temperature absorption coefficient for GaSe in the $E \parallel c$ geometry, with the free carriers absorption subtracted out.

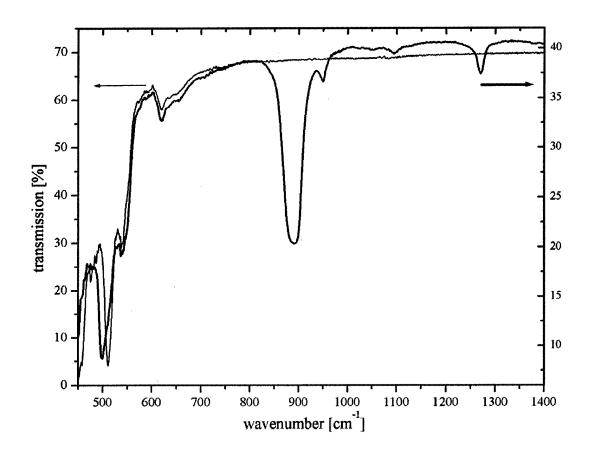
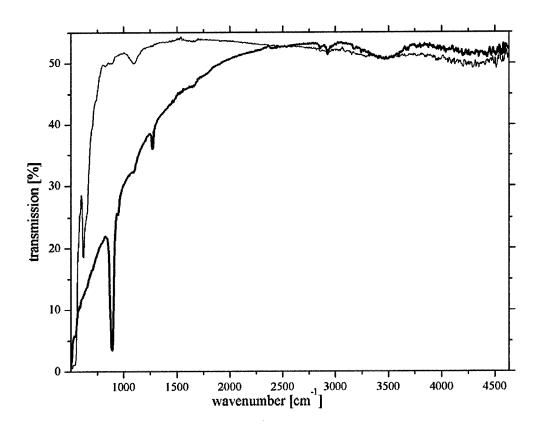


Figure 1



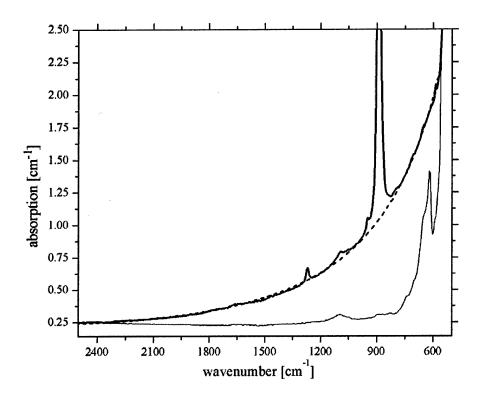


Figure 3

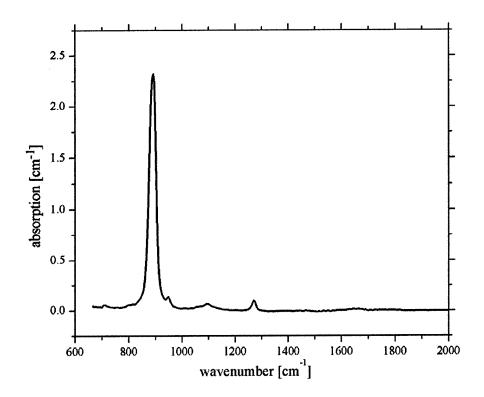


Figure 4

Table 1. Room-temperature IR absorption (reflection) bands of GaSe.

**Data obtained from the IR reflection and transmission spectra from freshly cleaved surface and surface containing the optical c- axis. Subscripts TO and LO denote the transverse and longitudinal phonon, respectively.

*Data obtained from the absorption spectra of freshly cleaved crystals, measured in non-polarized light in the geometry when the wave vector of the incident light was parallel to the optical c- axis.

Ref.	Band position, cm ⁻¹ , E⊥c (o-ray)	Ref.	Band position, cm ⁻¹ , E c (e-ray)
[2]**	231 _{TO} , 254 _{LO} , 423, 445, 476, 511, 539	[2]**	237 _{TO} , 246 _{LO} , 318, 360, 416, 495
[3]*	40, 211 _{TO}		
[4]**	214 _{TO} , 255 _{LO}		
[5]*	20 (2K), 211 _{TO} , 254 _{LO}		
[6] **	215 _{TO} , 252 _{LO}	[6]**	236 _{TO} , 247 _{LO}
[7]**	214 _{TO} , 254 _{LO}		
[8]*	214 _{TO} , 252 _{LO}		
[9]**	212 _{TO} , 254 _{LO}	[9]**	237 _{TO} , 245 _{LO}
[10]**	212 _{TO} , 255 _{LO}		
present	499, 512, 540, 619, 655		891, 945, 1093, 1270
work			